

Search Notes

Application/Control No.

10/768,543

Examiner

Winnie Yip

Applicant(s)/Patent under
Reexamination

FOUST ET AL.

Art Unit

3636

SEARCHED

Class	Subclass	Date	Examiner
52	167.1 223.4 720.1 721.2 745.17	9/30/2007	WSY
	295 721.4		
	723.1		
	736.1		
	742.14		
	741.14		
264	35 228 310		
425	111 126		
	289 137.1		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
52	223.4	9/4/2007	WSY
52	745.17		
52	721.2		
264/228, 310; 425/111 Text Searched in EAST (printout att.)			

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR